

Generic Copy

#### 10-Feb-2010

TITLE: Changed from Matrix 270 mils to HDLF 250 mils pad size, PLCC 44L

**PROPOSED FIRST SHIP DATE**: 10-May-2010

AFFECTED CHANGE CATEGORY(S): Assembly Manufacturing

#### FOR ANY QUESTIONS CONCERNING THIS NOTIFICATION:

Contact your local ON Semiconductor Sales Office or < Henry. Hernandez@onsemi.com >

**SAMPLES**: Contact your local ON Semiconductor Sales Office or < <a href="mailto:lsa.Calderon@onsemi.com">lsa.Calderon@onsemi.com</a>>

#### **ADDITIONAL RELIABILITY DATA:** Available

Contact your local ON Semiconductor Sales Office or <<u>Mark.Wasilewski@onsemi.com</u>>

#### **NOTIFICATION TYPE:**

Final Product/Process Change Notification (FPCN)

Final change notification sent to customers. FPCNs are issued at least 90 days prior to implementation of the change.

ON Semiconductor will consider this change approved unless specific conditions of acceptance are provided in writing within 30 days of receipt of this notice. To do so, contact <quality@onsemi.com>.

#### **DESCRIPTION AND PURPOSE:**

- To Change the Lead frame matrix 270 mils pad size with sid#101305388 to HDLF 250 mils pad size with sid# 101312688 with the following reason as follows:
  - ➤ Matrix 270 mils pad size no longer available
  - Increasing manufacturing efficiency and equipment utilization using high density lead frame
- No changes on lead frame material and package outline except for pad size from 270 mils to 250 mils. This pad size changed has no impact on assembly workmanship and within the assembly design rule.

Issue Date: 10-Feb-2010 Rev. 06-Jan-2010 Page 1 of 6



# **RELIABILITY DATA SUMMARY:**

The assembly qualification tests have concluded with passing results. Qualification was run according to ON Semiconductor Global Specification 1000019, ON Semiconductor Assembly Reliability Qualification. ON Semiconductor releases the package and materials set under consideration for dry pack level 3 of IPC/JEDEC standard J-STD-020 (Moisture/Reflow Sensitivity Classification for Non-Hermetic Solid State Surface Mount Devices).

This qualification covers PLCC's with maximum die size area of 41.58 mm<sup>2</sup> and maximum pin count of 52 pins assembled at Amkor Technology Philippines.

# **TEST VEHICLE IDENTIFICATION**

Device Identification : 11804-002
Lot Identification : B88473.1
Lot Assembly Tracecode : 0942NAW
Die-attach Material : 8361J EPOXY
Mold compound : EME-G600
Die Coat Material : Not applicable
Leadframe Material : Copper

Lead Finish : Matte Tin Plating

Lot Assembly House : Amkor Technology Philippines, Plant 2

Package pin count : 44L PLCC

Pad size : 6.859 mm x 6.859 mm Die Size : 6.00 mm x 4.95 mm

Package marking : LASER
Wire bond method : Ball - Stitch
Wire bond material : 1.2 Mil Gold

# **Reliability Test Results:**

#### MOISTURE RESISTANCE TEST

TEST SEQUENCE	SAMPLE SIZE	FAILURES OBSERVED	FAILURES ALLOWED	JUDGMENT	
ACOUSTIC MICROSCOPY INSPECTION	154	0	0	PASSED	
BAKE DRY, 21 HOURS AT 125°C	154	Not applicable			
MOISTURE ABSORPTION, 30°C/60% RH FOR 192 HOURS	154	Not applicable			
REFLOW SOLDERING, 3X AT 260°C	154	Not applicable			
FUNCTIONAL TESTING	154	0	0	PASSED	
ACOUSTIC MICROSCOPY INSPECTION	154	0		PASSED	

#### Remarks:

No functional failures were observed after Moisture Resistance Test. Also, no delaminations were found upon acoustic microscopy inspection after the stress. Device passed Moisture Resistance Test.

Issue Date: 01-Feb-2010 Rev. 06-Jan-2010 Page 2 of 6



#### THERMO-HUMIDITY TEST

TEST SEQUENCE	SAMPLE SIZE	FAILURES OBSERVED	FAILURES ALLOWED	JUDGMENT
MOISTURE RESISTANCE TEST	154	0	0	PASSED
PRECONDITIONING TEMPERATURE CYCLING TEST, 100X AT -55°C/125°C	77	Not applicable		
FUNCTIONAL TEST	77	0	0	PASSED
ACOUSTIC MICROSCOPY INSPECTION	77	0	0	PASSED
UNBIASED-HAST, 130°C/85% RH FOR 96 HOURS	77	Not applicable		
FUNCTIONAL TEST	77	0	0	PASSED
ACOUSTIC MICROSCOPY INSPECTION	77	0	0	PASSED

#### Remarks:

No functional failures were observed after Thermo-humidity Test. Small amount of delaminations were found between the lead fingers and mold compound upon acoustic microscopy inspection after stress. Device passed Thermo-humidity Test.

#### THERMO-MECHANICAL TEST

TEST SEQUENCE	SAMPLE SIZE	FAILURES OBSERVED	FAILURES ALLOWED	JUDGMENT
MOISTURE RESISTANCE TEST	154	0	0	PASSED
TEMPERATURE CYCLING TEST, 500X AT -65°C/150°C	77	Not applicable		
FUNCTIONAL TEST	77	0	0	PASSED
ACOUSTIC MICROSCOPY INSPECTION	77	0		PASSED
BOND-PULL TEST <sup>1</sup>	5	0	0	PASSED

<sup>&</sup>lt;sup>1</sup>Bond pull test was done on 100 wires from 5 parts with 2.5 grams minimum reading as passing criterion.

#### Remarks:

No functional failures were observed after Thermo-mechanical Test. Small amount of delaminations were found between the lead fingers and mold compound upon acoustic microscopy inspection after the stress. . Also, package passed post-TC Bond-Pull Test with Cpk = 1.52. Device passed Thermo-mechanical Test.

Issue Date: 01-Feb-2010 Rev. 06-Jan-2010 Page 3 of 6



# HIGH TEMPERATURE STORAGE TEST

TEST SEQUENCE	SAMPLE SIZE	FAILURES OBSERVED	FAILURES ALLOWED	JUDGMENT
FUNCTIONAL TEST	77	0	0	PASSED
HIGH TEMPERATURE STORAGE TEST, 150°C FOR 500H	77	Not applicable		
FUNCTIONAL TEST	77	0	0	PASSED
HIGH TEMPERATURE STORAGE TEST, 150°C FOR 1000H	77			
FUNCTIONAL TEST	77	0	0	PASSED

#### Remarks:

No functional failures were observed after High Temperature Storage Test. Device passed HTS Test.

#### **INTERNAL INSPECTION**

TEST SEQUENCE	SAMPLE SIZE	FAILURES OBSERVED	FAILURES ALLOWED	JUDGMENT
X-RAY INSPECTION	15	0	0	PASSED
SCANNING ACOUSTIC MICROSCOPY	15	0	0	PASSED
INTERNAL VISUAL	10	0	0	PASSED
BOND PULL TEST <sup>1</sup>	5	0	0	PASSED
BOND SHEAR TEST <sup>2</sup>	5	0	0	PASSED

### Remarks:

No workmanship problems were detected during the internal contact tests of the PLCC package. All test results are positive and passed the qualification requirements.

# **EXTERNAL INSPECTION**

TEST SEQUENCE	SAMPLE SIZE	FAILURES OBSERVED	FAILURES ALLOWED	JUDGMENT
EXTERNAL VISUAL	ALL	0	0	PASSED
PHYSICAL DIMENSIONS INSPECTION	10	0	0	PASSED
SOLDERABILITY TEST	15	0	0	PASSED

# Remarks:

No workmanship problems were detected during the external inspection of PLCC package.

Issue Date: 01-Feb-2010 Rev. 06-Jan-2010 Page 4 of 6



# **ELECTRICAL CHARACTERISTIC SUMMARY:**

Not applicable

# <u>CHANGED PART IDENTIFICATION</u>: Not applicable

Issue Date: 01-Feb-2010 Rev. 06-Jan-2010 Page 5 of 6



# **List of affected General Parts:**

11804-001-XTP

11804-002-XTP

20552-001-XTP

11060-001-XTD

11411-001-XTD

11411-002-XTD

Issue Date: 01-Feb-2010 Rev. 06-Jan-2010 Page 6 of 6